

**Notice of References Cited**

Application/Control No.

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Applicant(s)/Patent Under  
Reexamination  
KAPLAN, ALAN EDWARD

Examiner

Quynh H Nguyen

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,626,627	12-1986	Van Giliuwe et al.	379/214.01
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
	K	US-			
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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